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**Fine ceramics (advanced ceramics,
advanced technical ceramics) —
Determination of fracture toughness of
monolithic ceramics at room temperature
by the surface crack in flexure (SCF)
method**

*Céramiques techniques — Détermination de la ténacité à la rupture des
céramiques monolithiques à température ambiante par fissuration
superficielle en flexion*



Reference number
ISO 18756:2003(E)

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Foreword

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